

Integrated Device Technology, Inc. 6024 Silver Creek Valley Road, San Jose, CA - 95138

PRODUCT/PRO	CESS CHANGE NOTIO	CE (PCN)
PCN #: N0905-01 DATE: June 3	3, 2009 MEANS OF DISTINGU	ISHING CHANGED DEVICES:
Products Affected: IDT82V3202, IDT82V32021 IDT82V3203A, IDT82V3203B Refer to the attachment for affected part Date Effective: September 3, 2009		51 and Above
Contact: Rodney Corpuz	Ouler	
Title:Product Quality AssurancePhone #:(408) 284-8261Fax #:(408) 284-1450E-mail:rcorpuz@idt.com	Attachment: Samples: Available not	Yes 🗌 No w
DESCRIPTION AND PURPOSE OF CHANGE	:	
□ Assembly Process devices list □ Equipment marking w □ Testing Attachment	ication is to advise our customers that ID sted on this PCN to be in compliant to the vill not change. Int 1 outlines the changes on the products. Int 2 shows a list of the affected part numb	I ² C standard. The product
RELIABILITY/QUALIFICATION SUMMARY	Y:	
There is no expected change to the product quality		
CUSTOMER ACKNOWLEDGMENT OF REC IDT records indicate that you require written notif to grant approval or request additional information it will be assumed that this change is acceptable.	ication of this change. Please use the ackr	
Customer:	Approval for ship	ments prior to effective date.
Name/Date:	E-Mail Address:	
Title:	Phone# /Fax# :	
CUSTOMER COMMENTS:		
IDT ACKNOWLEDGMENT OF RECEIPT:		
RECD. BY:	DATE:	
IDT FRA-1509-01 REV. 00 09/18/01	Page 1 of 1	Refer To QCA-1795



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PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT 1 - PCN # : N0905-01

PCN Type: Die Change

Data Sheet Change: Yes

Details Of Change:

This notification is to advise our customers that IDT made a die change on the listed devices to fix an I^2C design issue. The I^2C circuit of the device will not acknowledge a transaction during a write operation of I^2C registers for the mismatching addresses. If the device address does not match, data will not be written to the I^2C registers of the device.

According to I^2C standard, only ACK (low) signal should be returned from the selected slave device in response to its address. The device responds with an acknowledge (ACK) to all addresses on the I^2C bus during the address phase. This is not compliant to the I^2C standard.

The die has been redesigned to fix the problem. The product marking will not change. The die fix is indicated with top mark date code of 0851 and beyond.

Work-around

During device discovery, software must place the device in reset so that it will not "ACK" other device addresses. When the PLL is in normal operating mode, SW should not use polling mode for device acknowledgement.

Verification of die change:

This die change was verified to be effective for resolving the I^2C issue with validation of the device functionality and testing against the datasheet parameters

Description	Test Results
Bench Validation	PASSED
C Load Data	PASSED
Final Yield Data	NORMAL

Reliability:

The die revision was related to a specific application issue and product reliability is not affected.

Affected Devices: Refer to Attachment 2

Sample Availability:

Samples are now available for all affected devices. Please contact your local IDT sales representative for your sample request.



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PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT 2 - PCN # : N0905-01

Affected Part Numbers	
IDT82V32021NL	
IDT82V32021NLG	
IDT82V3202DKG	
IDT82V3202EDG	
IDT82V3202NL	
IDT82V3202NLG	
IDT82V3203ANL	
IDT82V3203ANLG	
IDT82V3203BNL	
IDT82V3203BNLG	